Radboud Universiteit

ESI

Model-Based Testing

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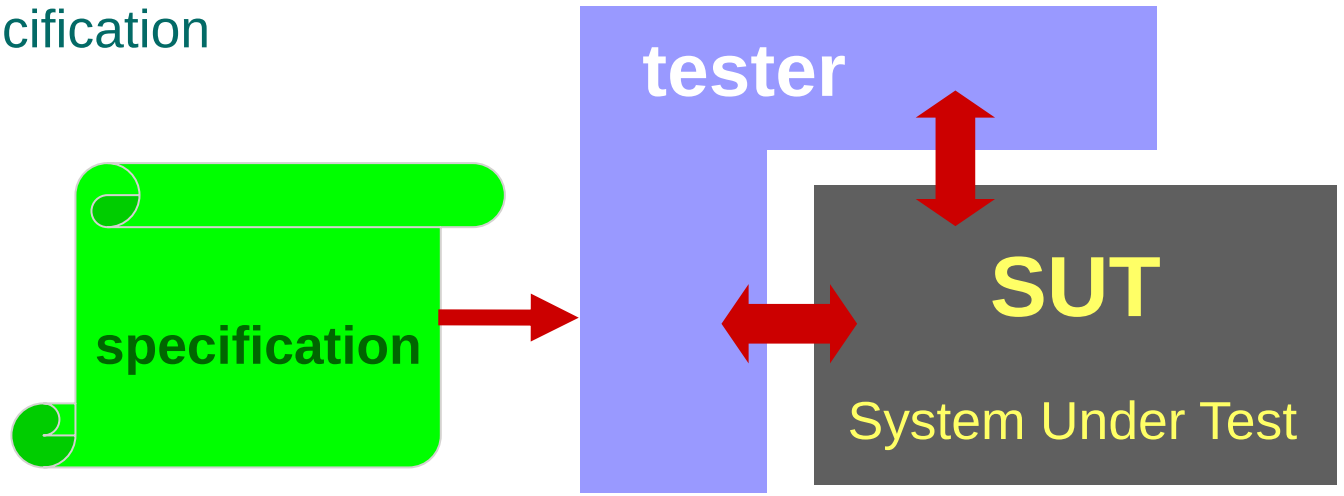
TNO innovation for life

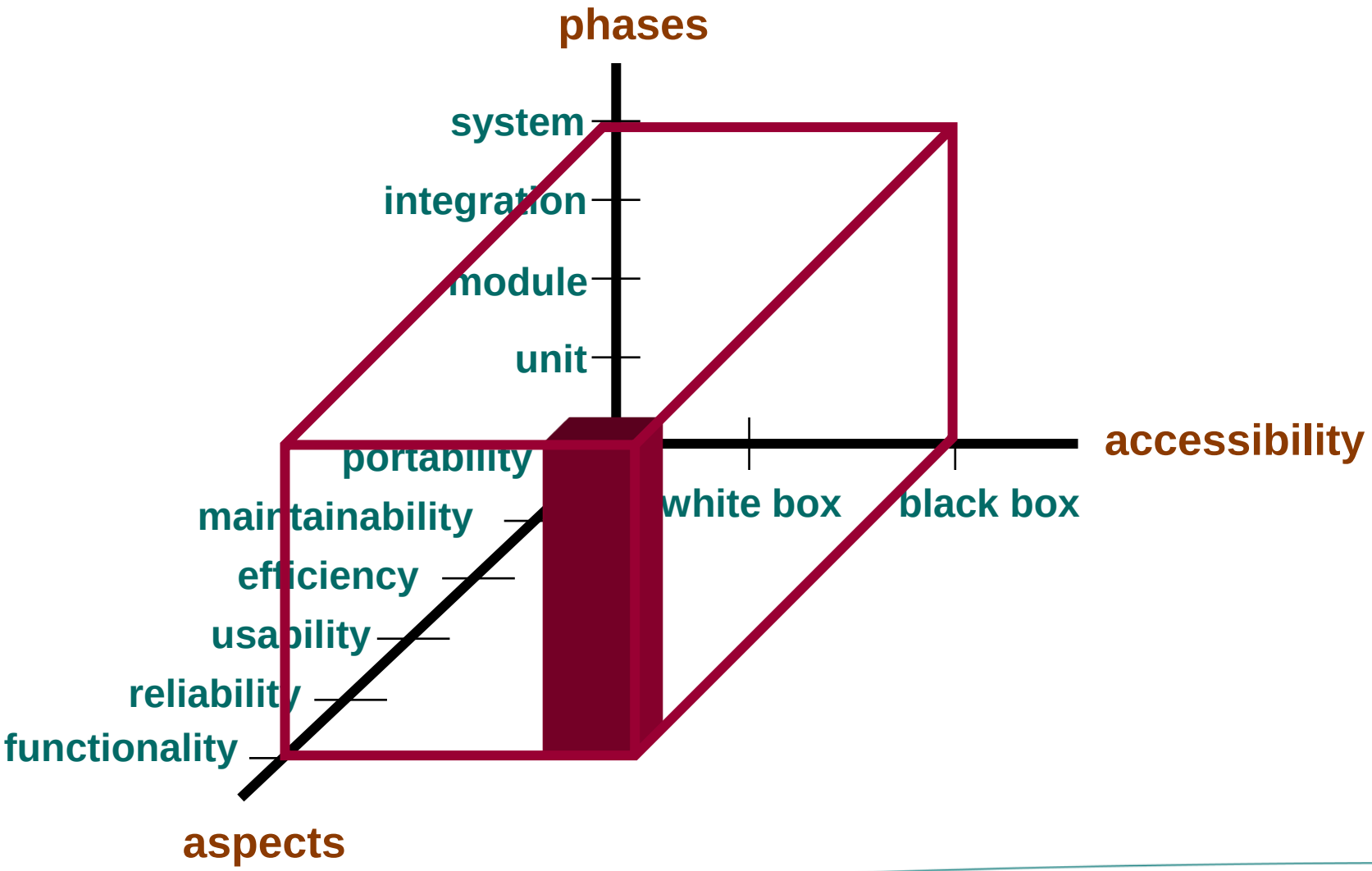
Software Testing

Checking or measuring
some quality characteristics
of an executing software object
by performing experiments
in a controlled way
w.r.t. a specification

specification-based, active, black-box testing of functionality



MBT : Black-Box Testing of Functionality



Model-Based Testing

Basics

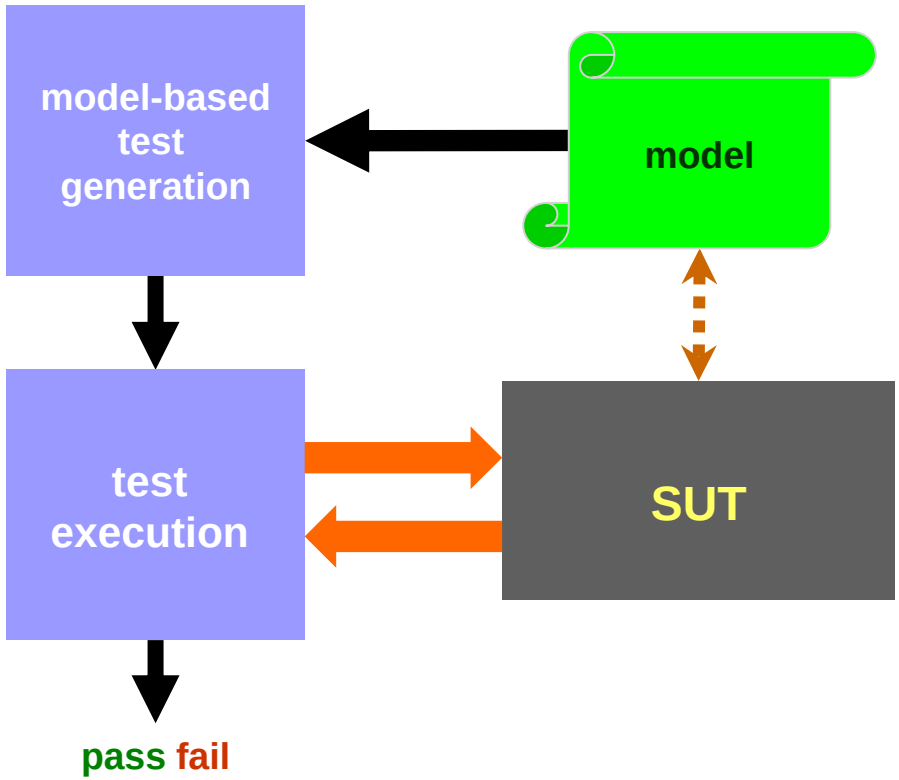
Model-Based Testing

MBT

next step in

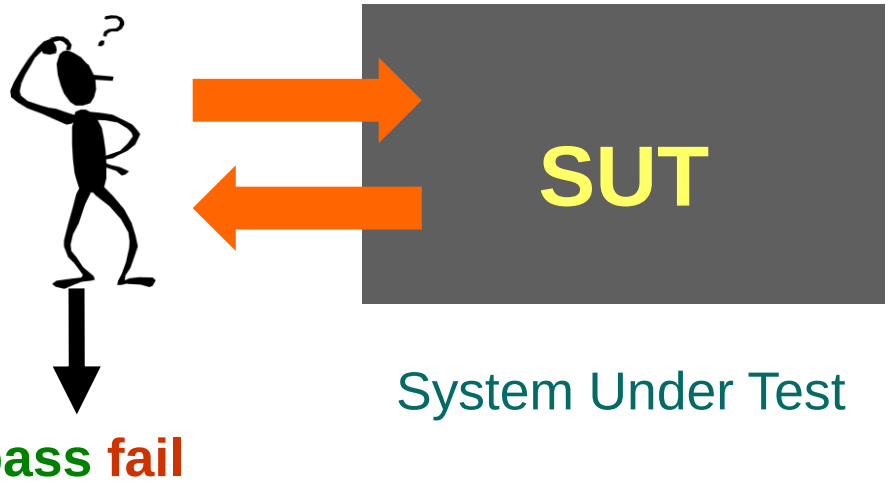
test automation:

- \+ test generation
- \+ result analysis

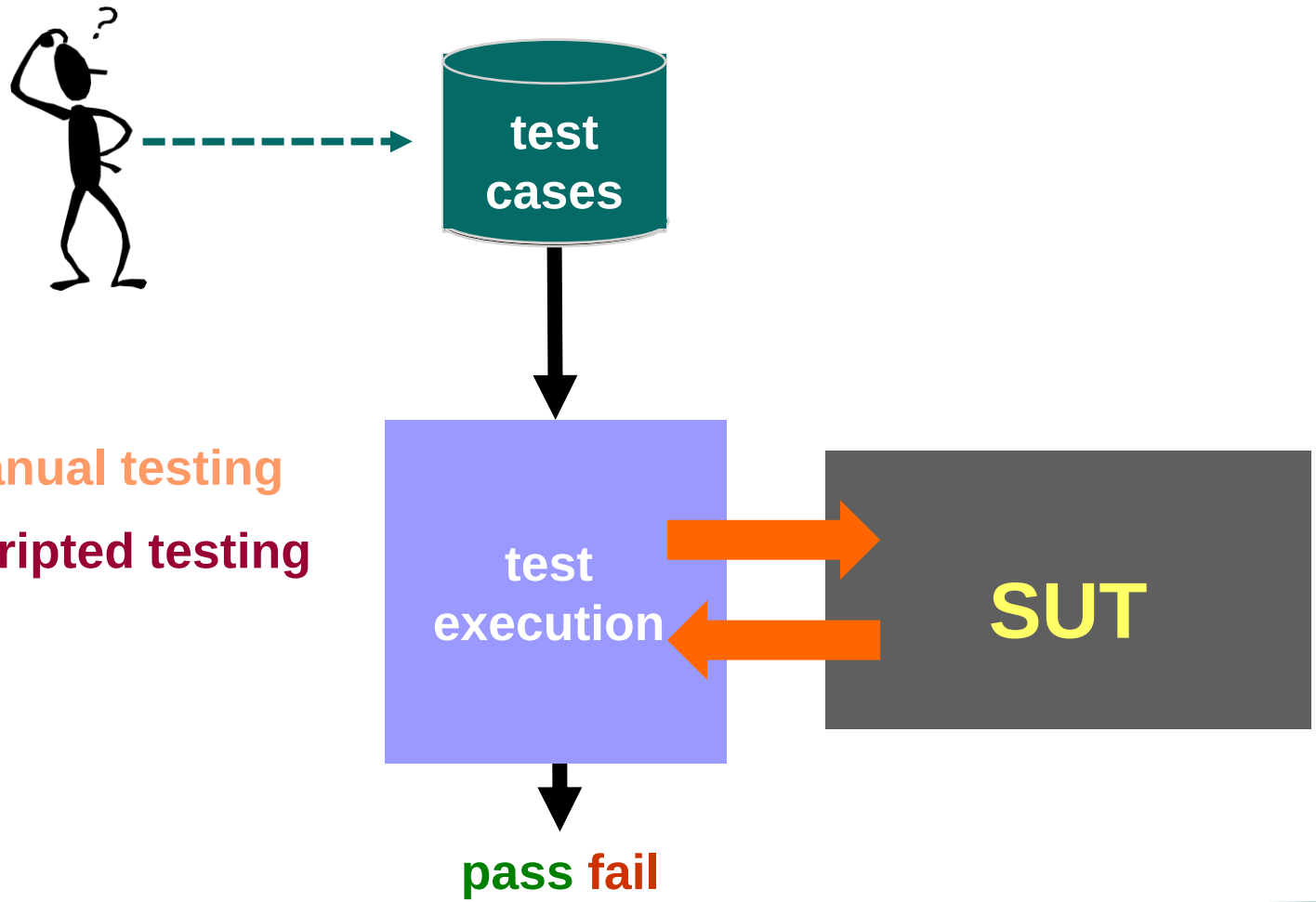


1 : Manual Testing

1. **Manual testing**

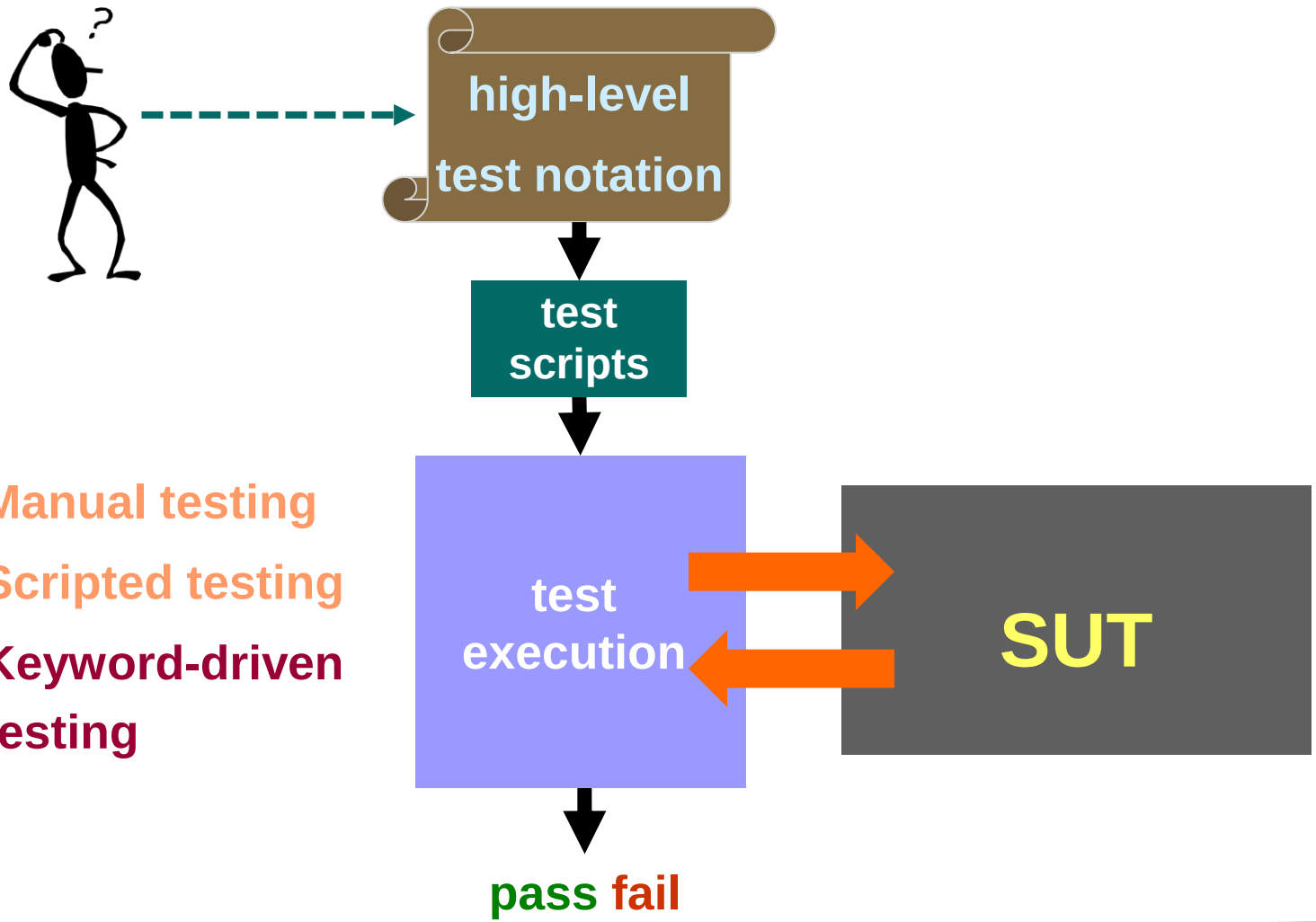


2 : Scripted Testing



1. Manual testing
2. Scripted testing

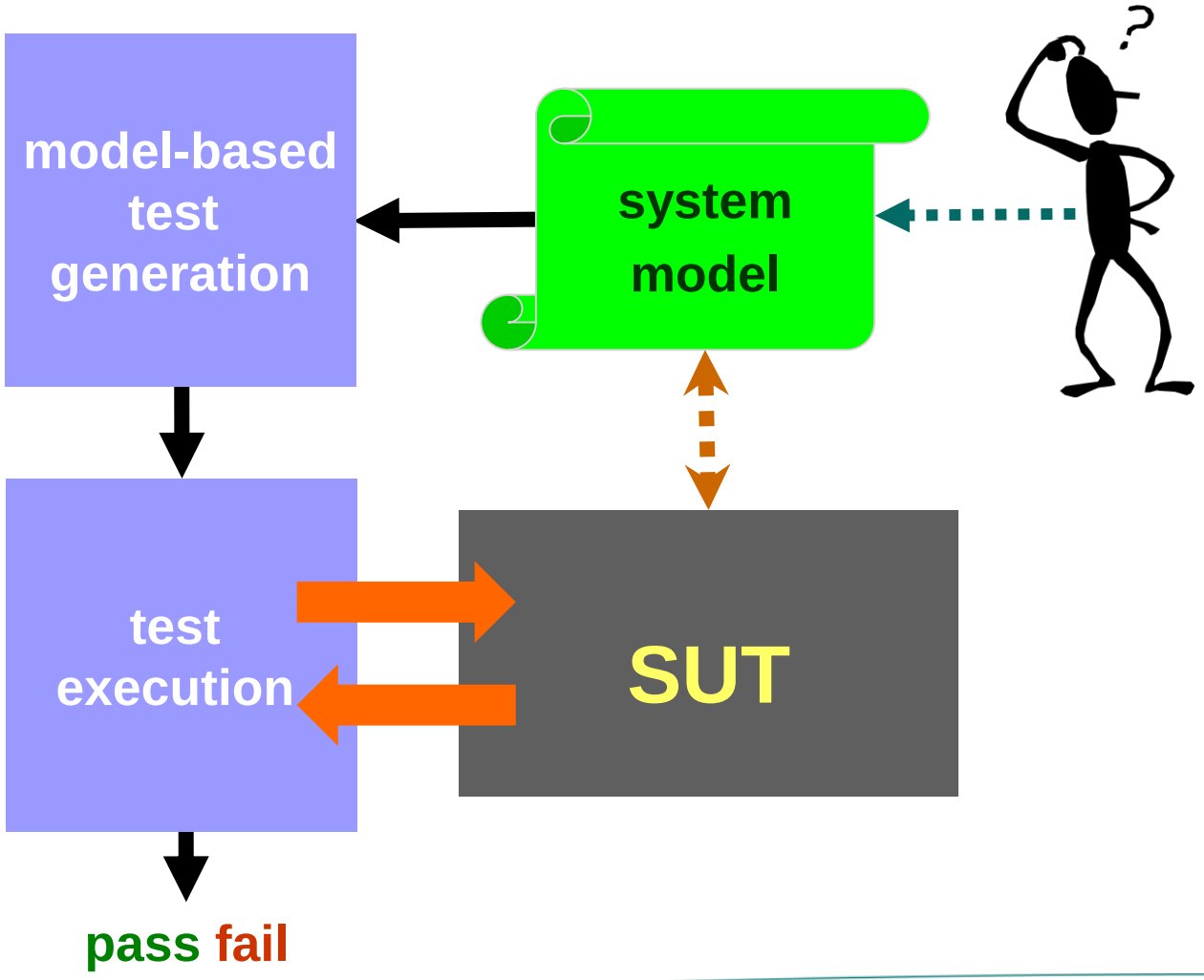
3 : Keyword-Driven Testing



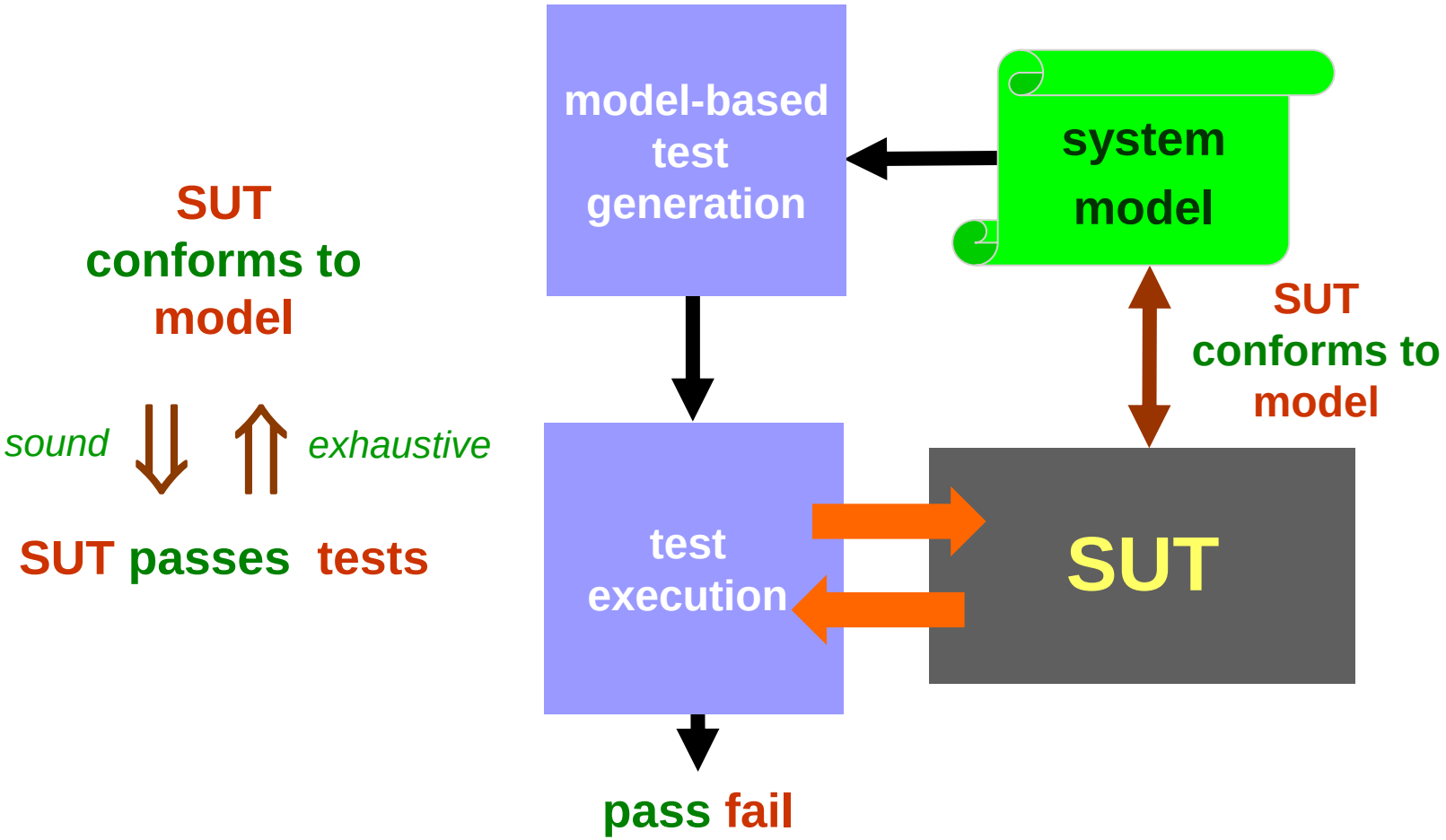
1. Manual testing
2. Scripted testing
3. **Keyword-driven testing**

4 : Model-Based Testing

1. Manual testing
2. Scripted testing
3. Keyword-driven testing
4. **Model-based testing**

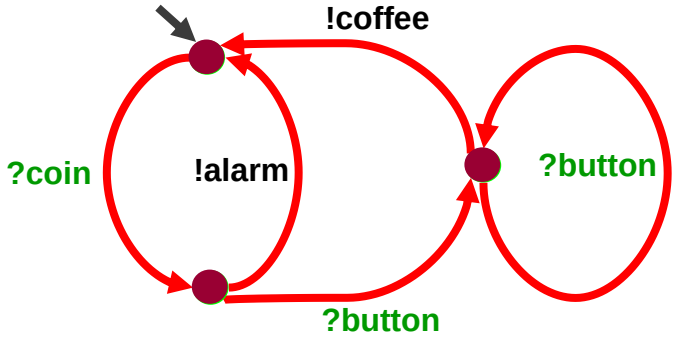


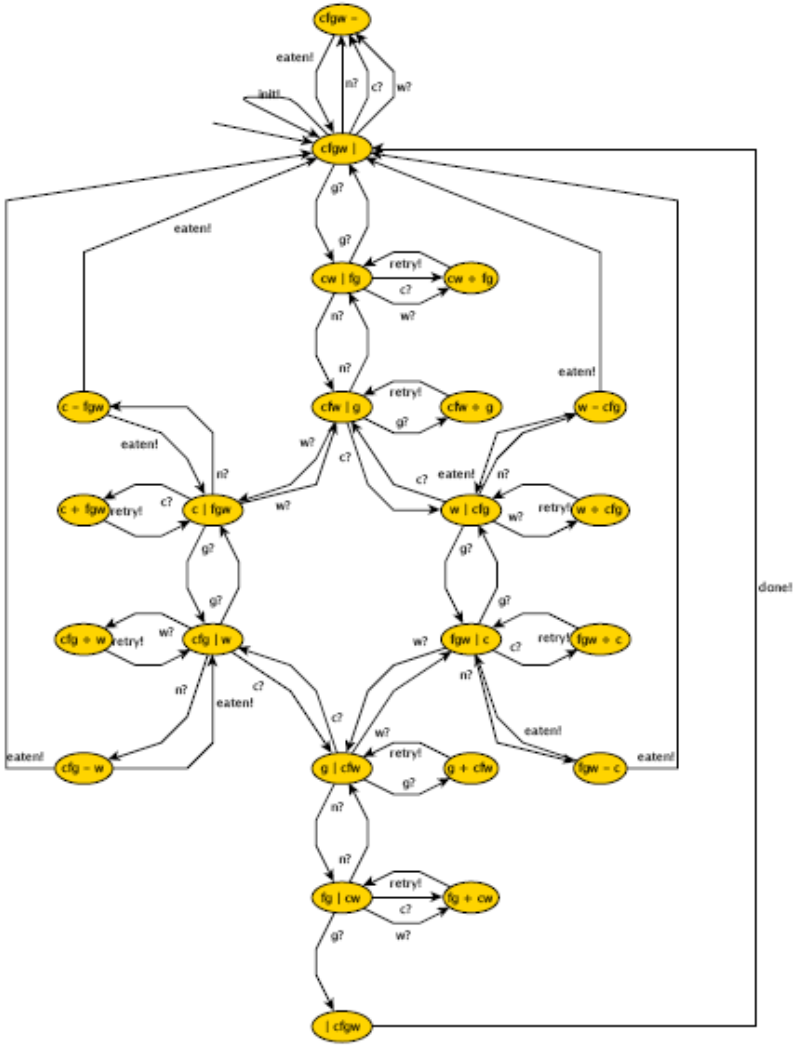
Model Based Testing

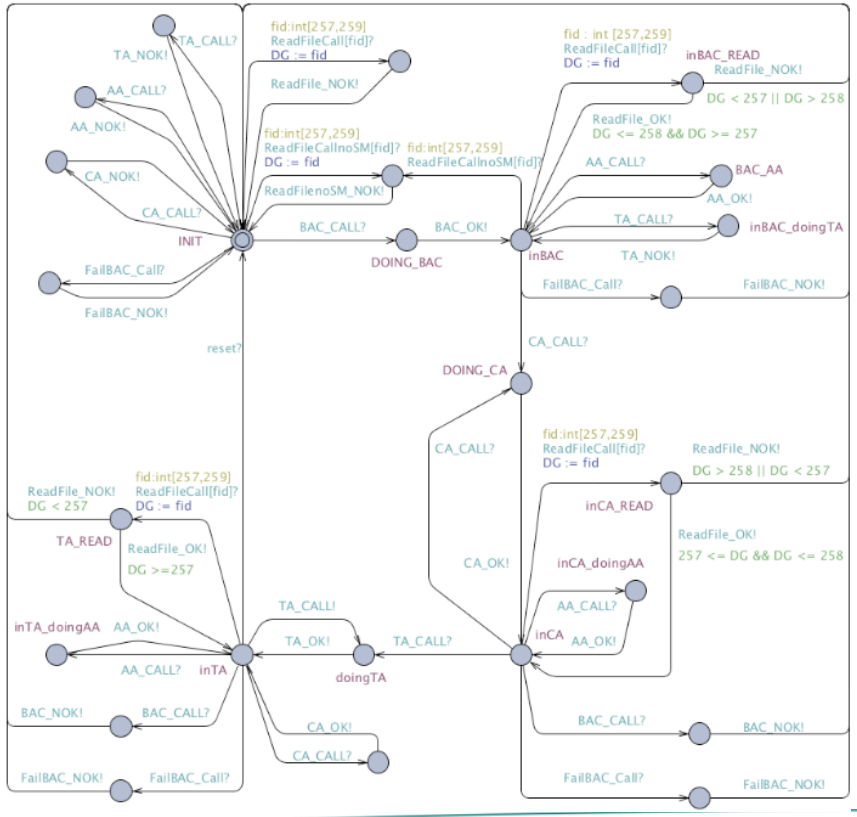


Models

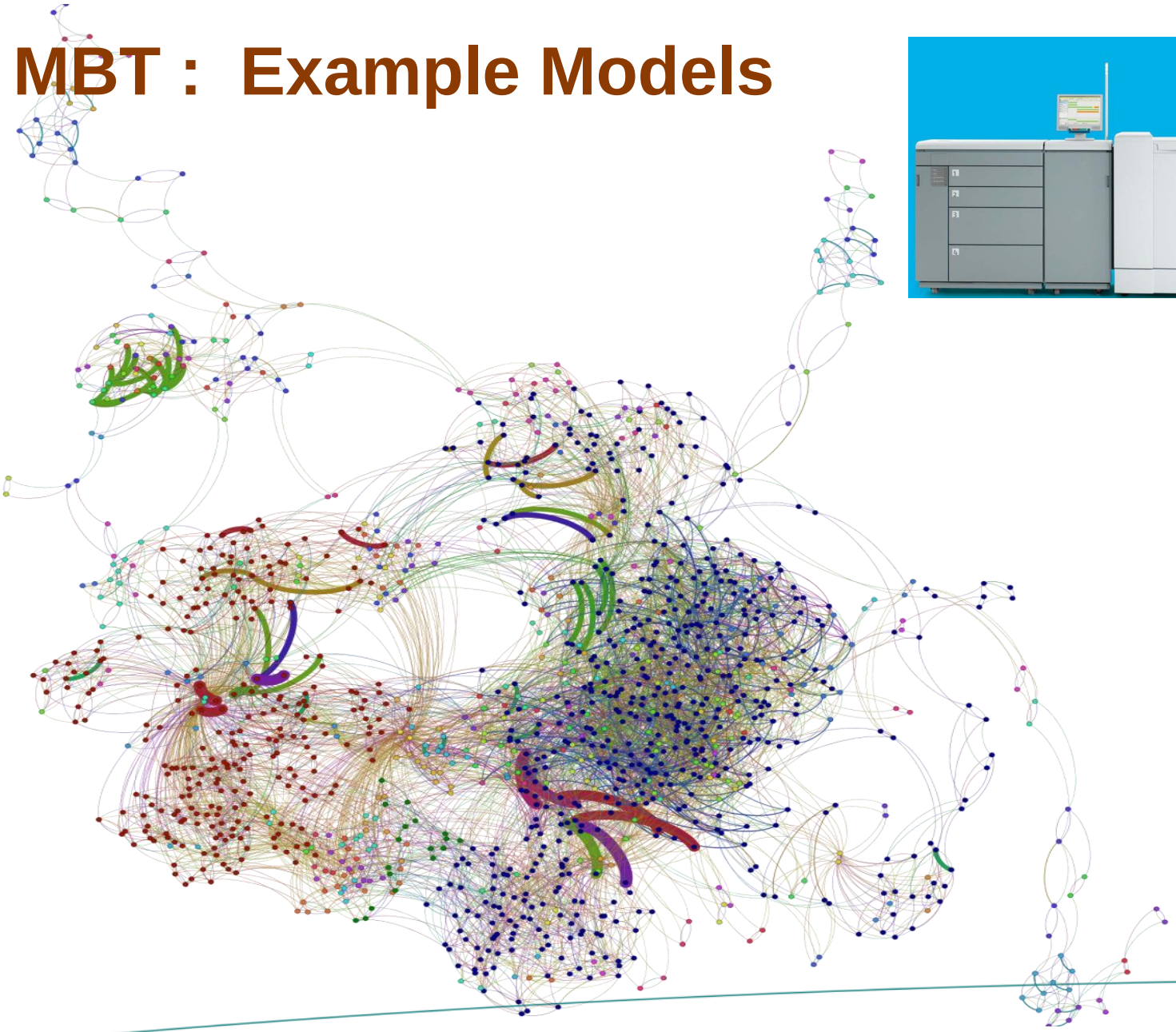
MBT : Example Models





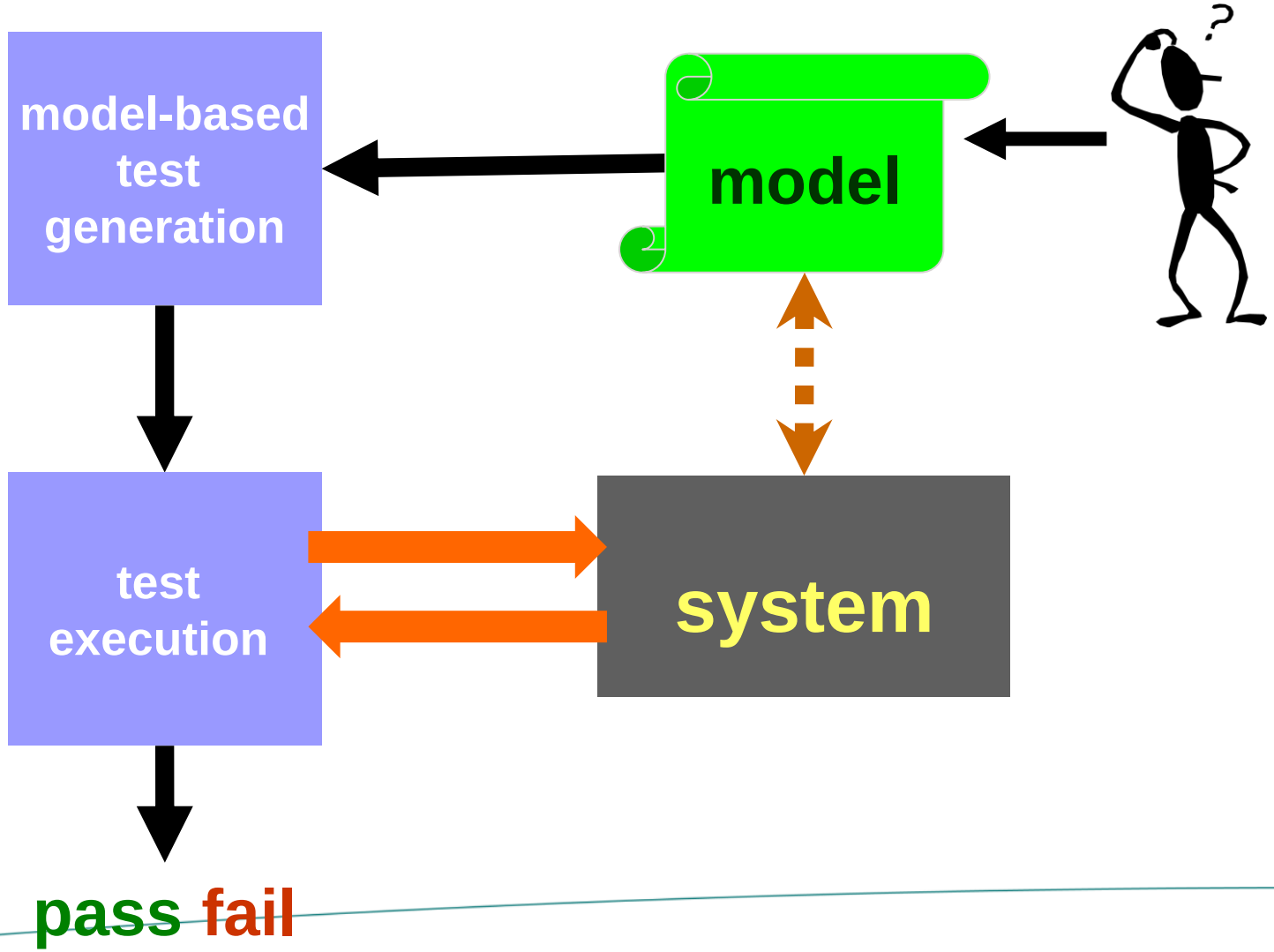


MBT : Example Models

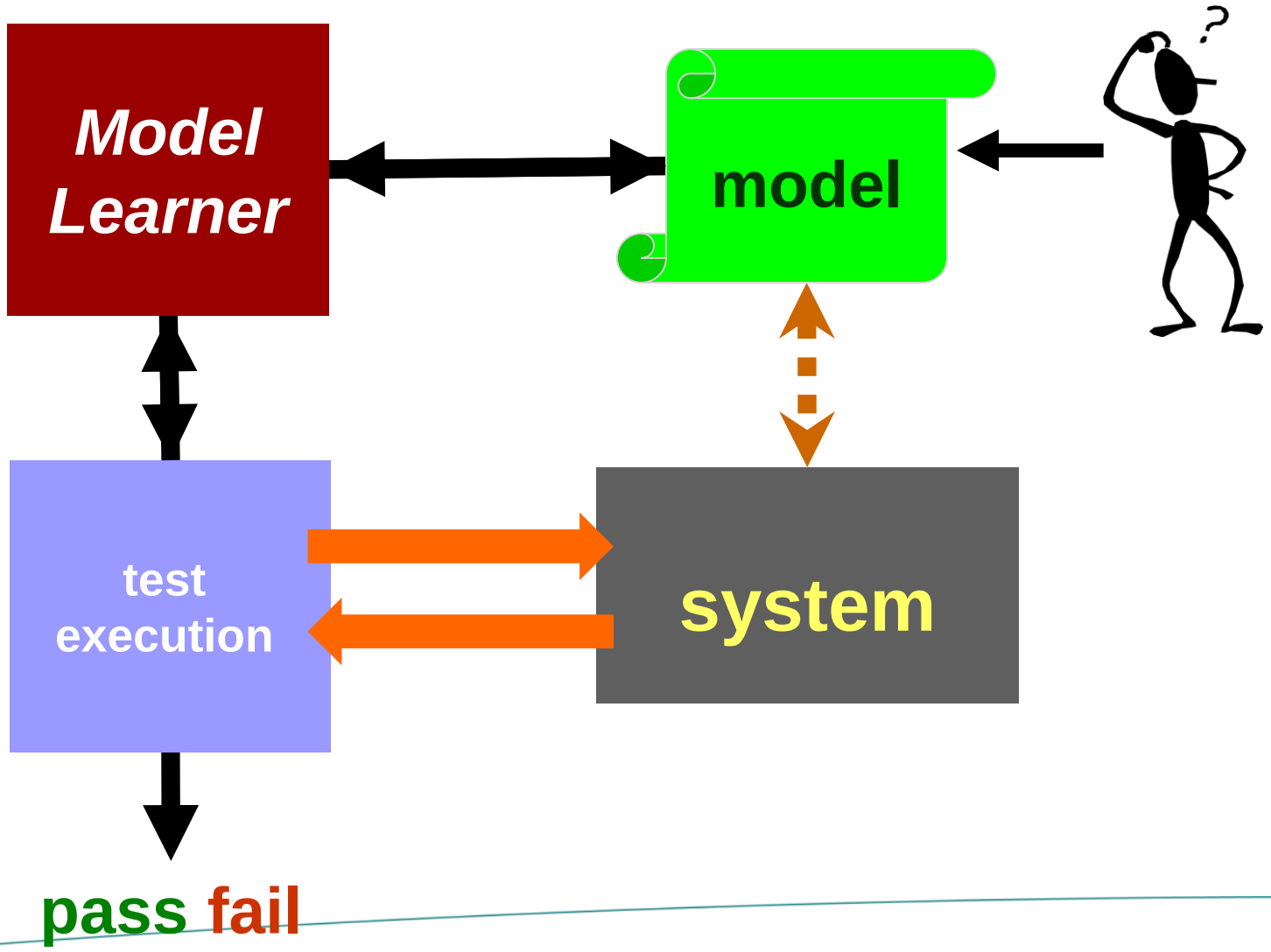


Model Learning

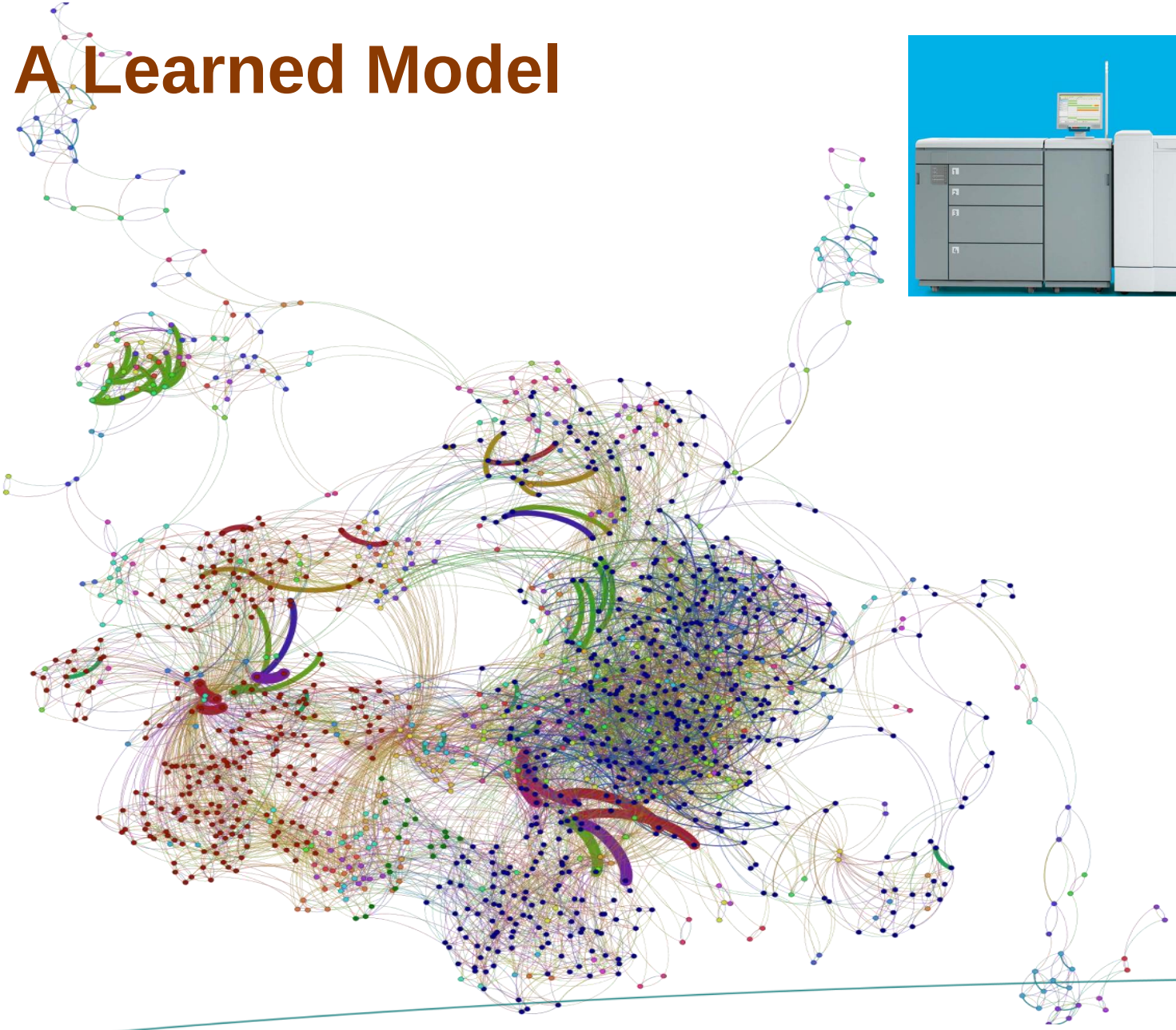
MBT : How to Get these D… Models



Research : Model Learning



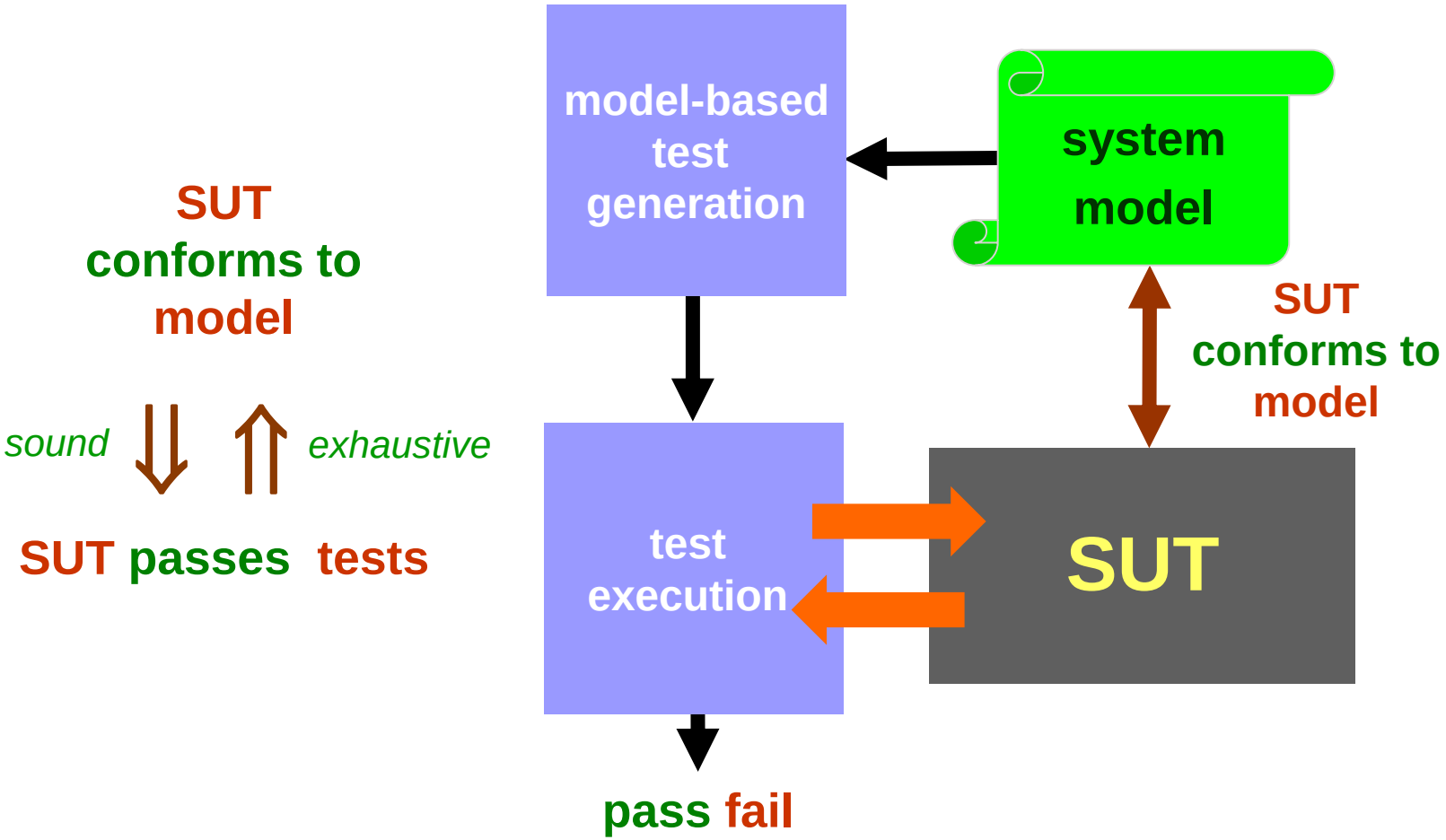
A Learned Model



Model-Based Testing

Theory

Model Based Testing

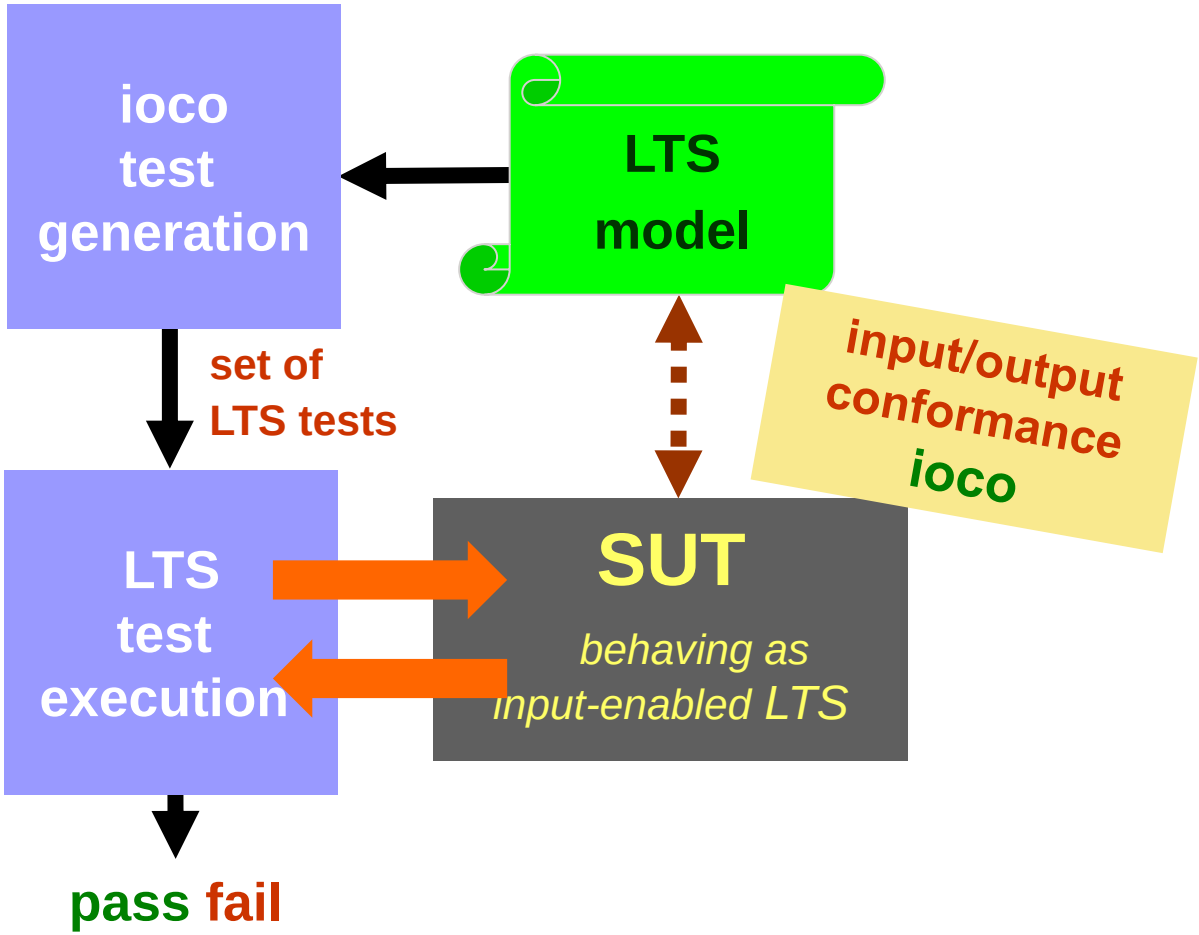


MBT : LTS & ioco

SUT ioco model

sound ⇓ ⇑ *exhaustive*

SUT passes tests



Model-Based Testing Theory with Labelled Transition Systems and **ioco**

Conformance : *ioco*

i ioco s $=_{def}$ $\forall \sigma \in$ ***Straces*** **(s) :** ***out*** **(i after** σ**)** $\subseteq$ ***out*** **(s after** σ**)**

s is a Labelled Transition System (LTS)

i is (assumed to be) an input-enabled LTS

$p \xrightarrow{\delta} p \quad = \quad \forall\ !x \in L_U \cup \{\tau\}\ .\ p \not\xrightarrow{!x}$

$Straces(s) \quad = \quad \{\ \sigma \in (L \cup \{\delta\})^*\ |\ s \stackrel{\sigma}{\Longrightarrow}\ \}$

$p \text{ after } \sigma \quad = \quad \{\ p' \ |\ p \stackrel{\sigma}{\Longrightarrow} p'\ \}$

$out(P) \ = \ \{\ !x \in L_U \ |\ p \xrightarrow{!x}, \ p \in P\ \} \ \cup \ \{\ \delta \ |\ p \xrightarrow{\delta} p, \ p \in P\ \}$

Conformance : *ioco*

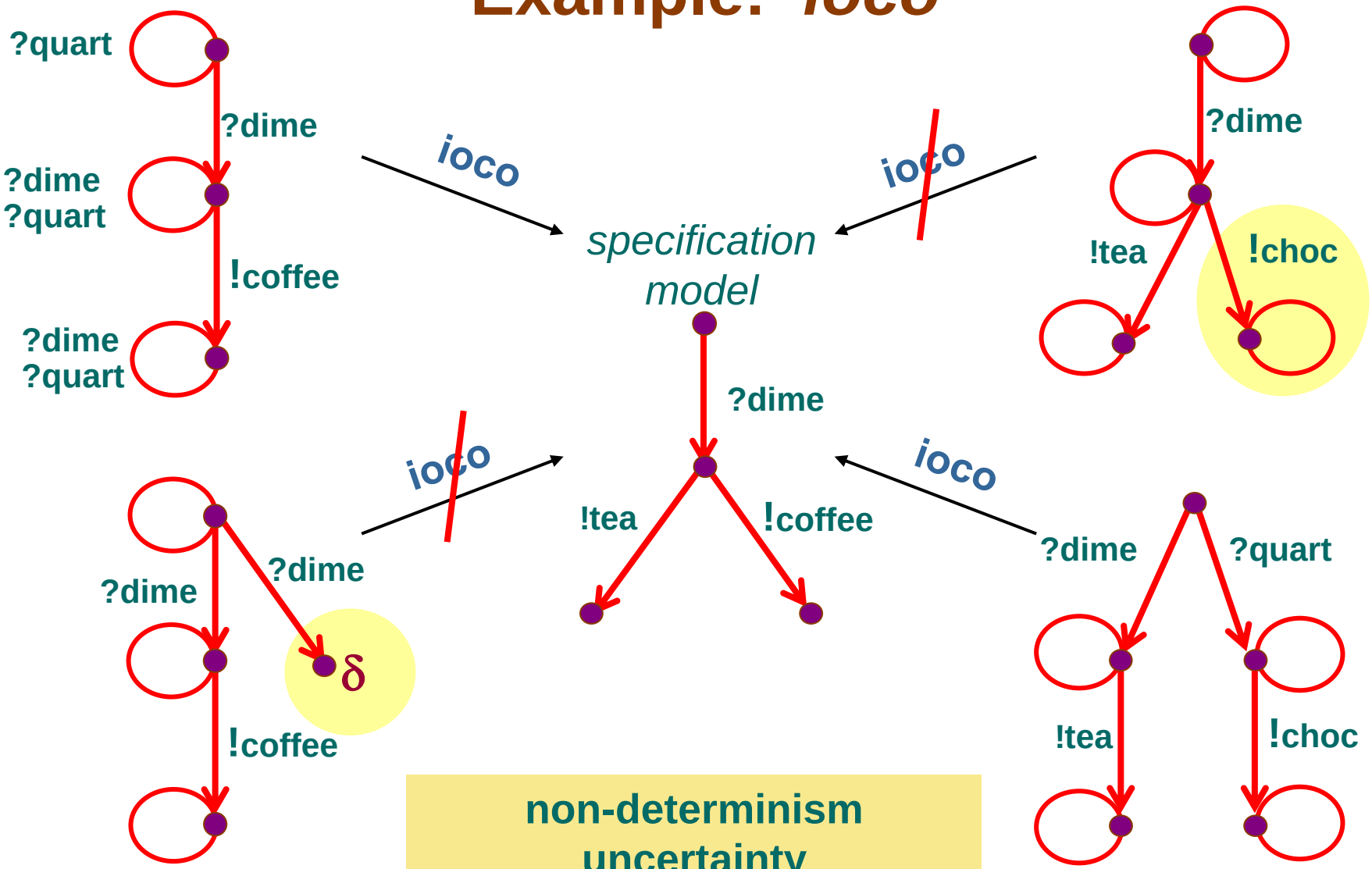
i ioco s $=_{def}$ $\forall \sigma \in$ *Straces* (s) : *out* (i after σ) $\subseteq$ *out* (s after σ)

Intuition:

i ioco-conforms to s, iff

- if i produces output x after trace σ,
  then s can produce x after σ
- if i cannot produce any output after trace σ,
  then s cannot produce any output after σ (*quiescence* δ)

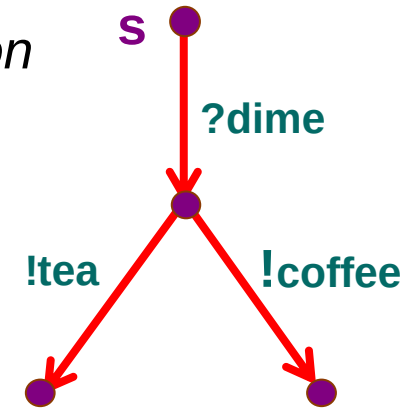
Example: *ioco*

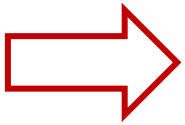


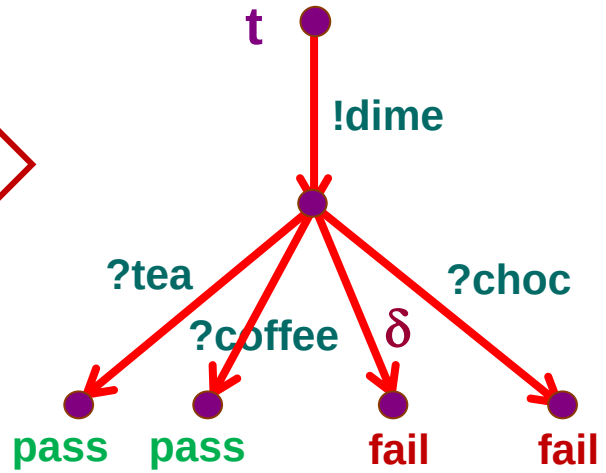
non-determinism
uncertainty
under-specification

Example: *ioco* Test Generation

specification model

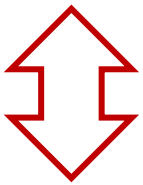




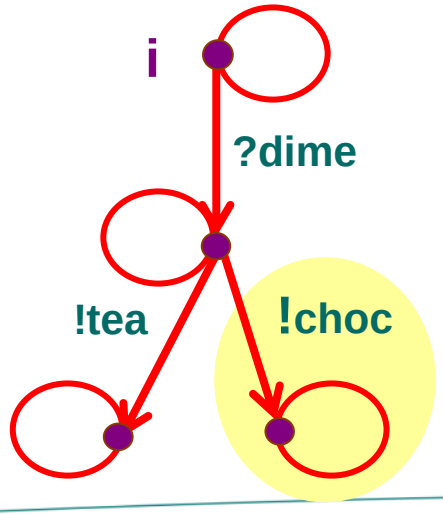


generated test case

i ioco s



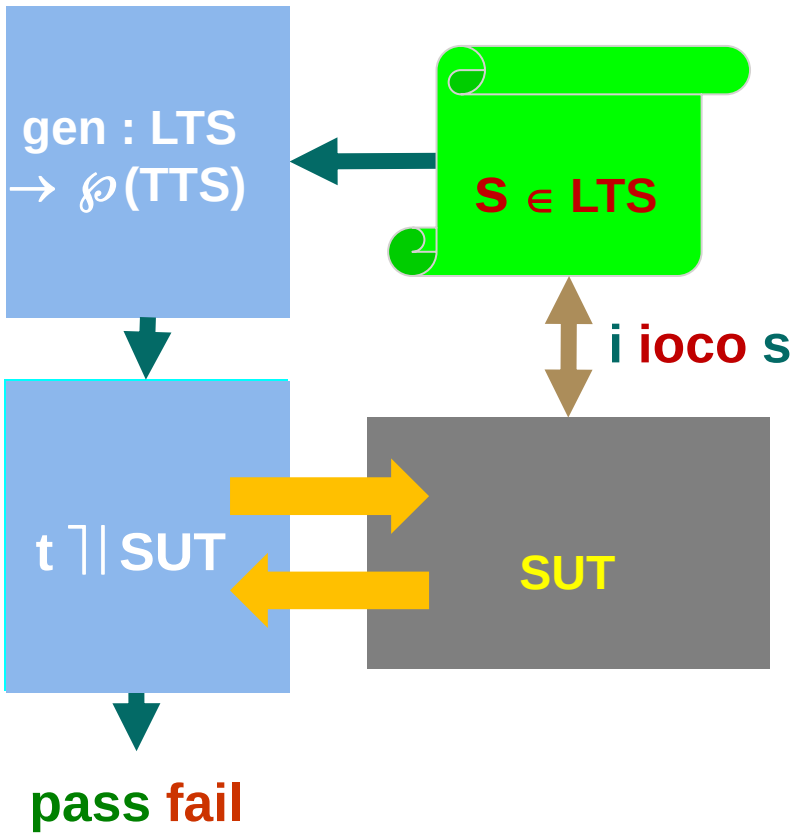
i fails t



implementation

i ioco s $=_{def}$
$\forall \sigma \in$ ***Straces*** **(s) :**
out **(i after** σ**)** $\subseteq$ ***out*** **(s after** σ**)**

MBT with *ioco* is Sound and Exhaustive



Test assumption :

$\forall SUT \in IMP \,.\, \exists m_{SUT} \in IOTS \,.$
$\forall t \in TESTS \,.$
SUT passes t $\Leftrightarrow$ m_{SUT} **passes** t

Prove soundness and exhaustiveness:

$\forall m \in IOTS \,.$
($\forall t \in gen(s)$. **m passes** t)
$\Leftrightarrow$ **m ioco s**

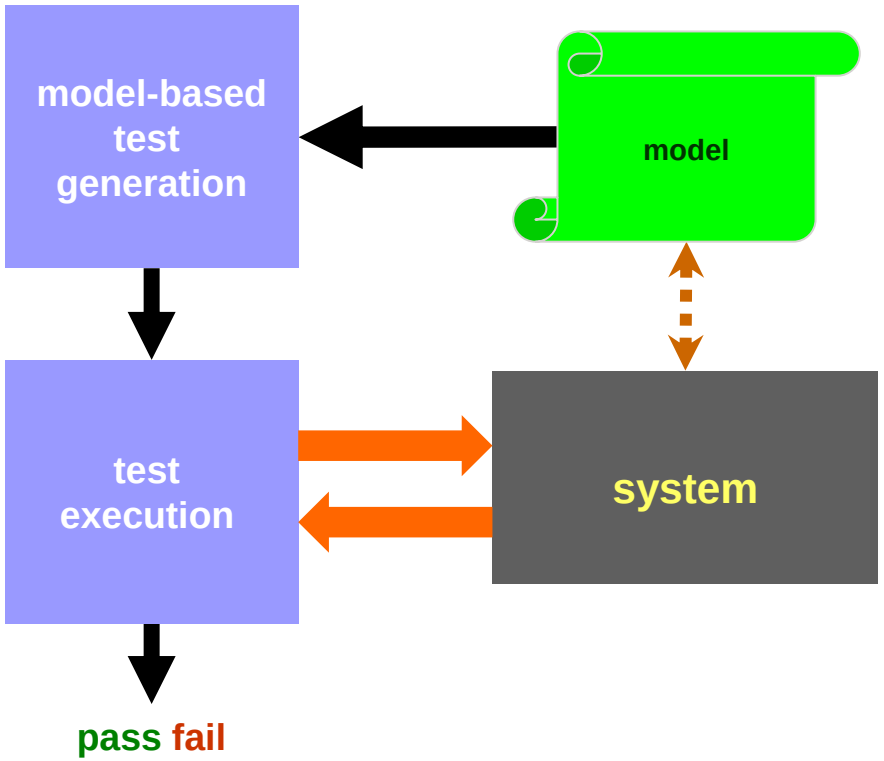
SUT comforms to s

exhaustive ⇑ ⇓ *sound*

SUT passes gen(s)

MBT

?


model-based test generation
model
test execution
system
pass fail